



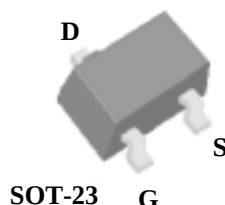
**Advanced Power
Electronics Corp.**

AP2311GN

Pb Free Plating Product

**P-CHANNEL ENHANCEMENT MODE
POWER MOSFET**

- ▼ Simple Drive Requirement
- ▼ Small Package Outline
- ▼ Surface Mount Device
- ▼ RoHS Compliant

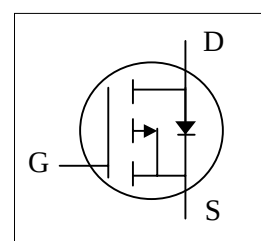


BV_{DSS}	-60V
$R_{DS(ON)}$	250m Ω
I_D	- 1.8A

Description

The Advanced Power MOSFETs from APEC provide the designer with the best combination of fast switching, low on-resistance and cost-effectiveness.

The SOT-23 package is universally preferred for all commercial-industrial surface mount applications and suited for low voltage applications such as DC/DC converters.



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	- 60	V
V_{GS}	Gate-Source Voltage	± 20	V
$I_D@T_A=25^{\circ}\text{C}$	Continuous Drain Current ³	- 1.8	A
$I_D@T_A=70^{\circ}\text{C}$	Continuous Drain Current ³	- 1.4	A
I_{DM}	Pulsed Drain Current ^{1,2}	-10	A
$P_D@T_A=25^{\circ}\text{C}$	Total Power Dissipation	1.38	W
	Linear Derating Factor	0.01	W/ $^{\circ}\text{C}$
T_{STG}	Storage Temperature Range	-55 to 150	$^{\circ}\text{C}$
T_J	Operating Junction Temperature Range	-55 to 150	$^{\circ}\text{C}$

Thermal Data

Symbol	Parameter	Value	Unit
R_{thj-a}	Thermal Resistance Junction-ambient ³ Max.	90	$^{\circ}\text{C}/\text{W}$



AP2311GN

Electrical Characteristics@T_j=25°C(unless otherwise specified)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =-250uA	-60	-	-	V
ΔBV _{DSS} /ΔT _j	Breakdown Voltage Temperature Coefficient	Reference to 25°C, I _D =-1mA	-	-0.04	-	V/°C
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-10V, I _D =-1.8A	-	200	250	mΩ
		V _{GS} =-4.5V, I _D =-1.4A	-	240	300	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250uA	-1	-	-3	V
g _{fs}	Forward Transconductance	V _{DS} =-10V, I _D =-1A	-	2	-	S
I _{DSS}	Drain-Source Leakage Current (T _j =25°C)	V _{DS} =-60V, V _{GS} =0V	-	-	-10	uA
	Drain-Source Leakage Current (T _j =70°C)	V _{DS} =-48V, V _{GS} =0V	-	-	-25	uA
I _{GSS}	Gate-Source Leakage	V _{GS} =±20V	-	-	±100	nA
Q _g	Total Gate Charge ²	I _D =-1A	-	6	10	nC
Q _{gs}	Gate-Source Charge	V _{DS} =-48V	-	1	-	nC
Q _{gd}	Gate-Drain ("Miller") Charge	V _{GS} =-4.5V	-	3	-	nC
t _{d(on)}	Turn-on Delay Time ²	V _{DS} =-30V	-	8	-	ns
t _r	Rise Time	I _D =-1A	-	5	-	ns
t _{d(off)}	Turn-off Delay Time	R _G =3.3Ω, V _{GS} =-10V	-	22	-	ns
t _f	Fall Time	R _D =30Ω	-	3	-	ns
C _{iss}	Input Capacitance	V _{GS} =0V	-	510	810	pF
C _{oss}	Output Capacitance	V _{DS} =-25V	-	50	-	pF
C _{rss}	Reverse Transfer Capacitance	f=1.0MHz	-	40	-	pF
R _g	Gate Resistance	f=1.0MHz	-	6.4	9.6	Ω

Source-Drain Diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Units
V _{SD}	Forward On Voltage ²	I _S =-1.2A, V _{GS} =0V	-	-	-1.2	V
t _{rr}	Reverse Recovery Time ²	I _S =-1A, V _{GS} =0V,	-	30	-	ns
Q _{rr}	Reverse Recovery Charge	dI/dt=100A/μs	-	38	-	nC

Notes:

- 1.Pulse width limited by Max. junction temperature.
- 2.Pulse width ≤300us , duty cycle ≤2%.
- 3.Surface mounted on 1 in² copper pad of FR4 board, t ≤10sec ; 270 °C/W when mounted on Min. copper pad.

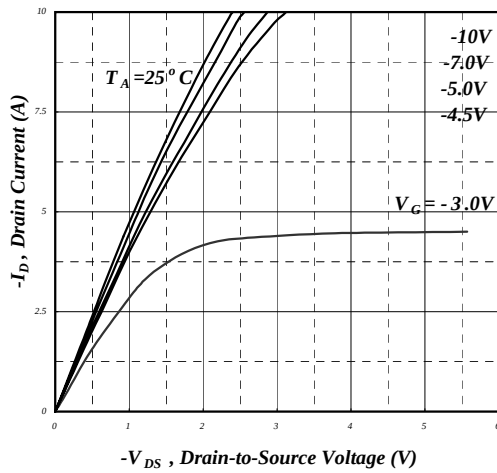


Fig 1. Typical Output Characteristics

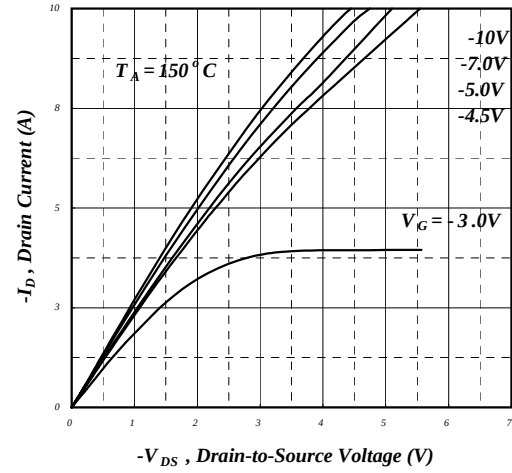


Fig 2. Typical Output Characteristics

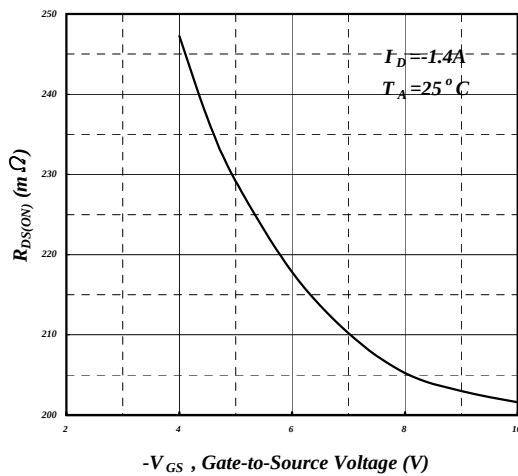


Fig 3. On-Resistance v.s. Gate Voltage

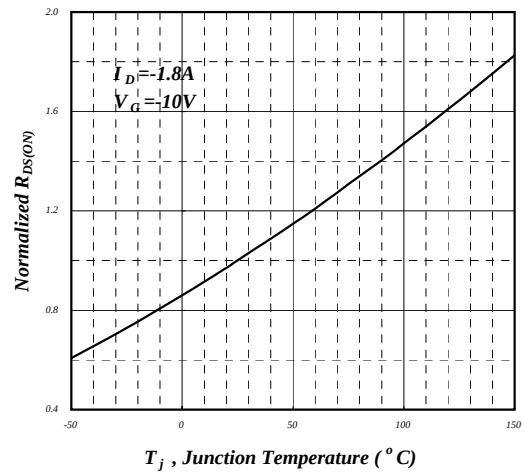


Fig 4. Normalized On-Resistance v.s. Junction Temperature

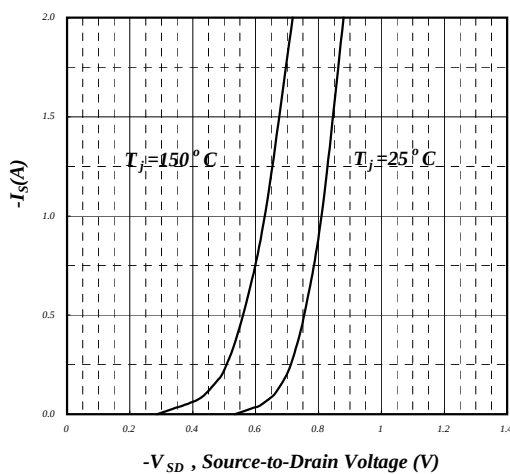


Fig 5. Forward Characteristic of

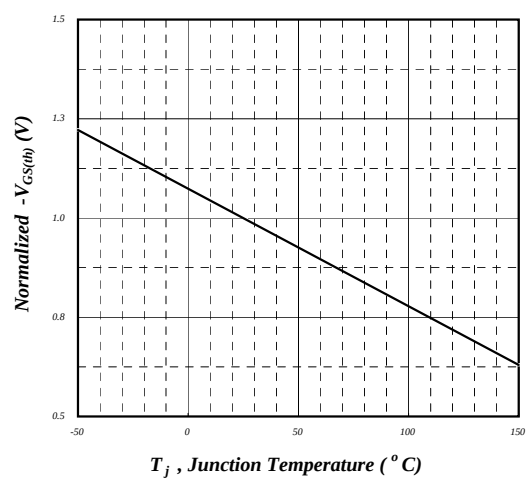


Fig 6. Gate Threshold Voltage v.s.

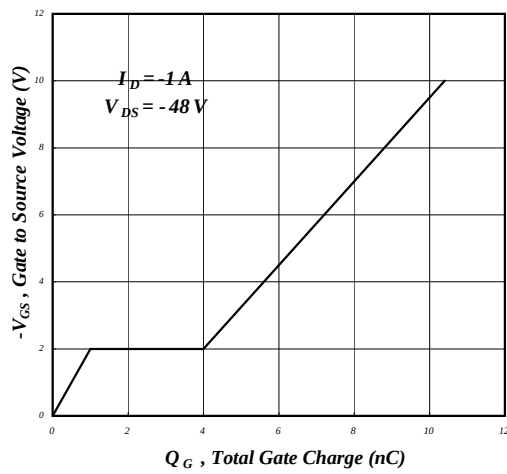


Fig 7. Gate Charge Characteristics

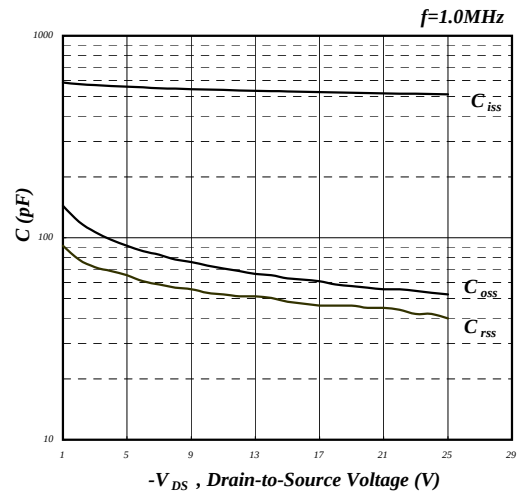


Fig 8. Typical Capacitance Characteristics

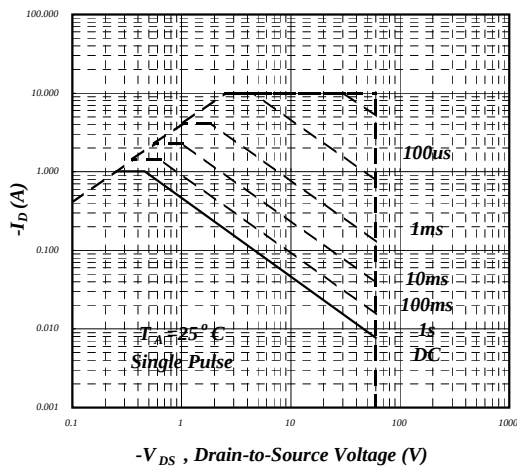


Fig 9. Maximum Safe Operating Area

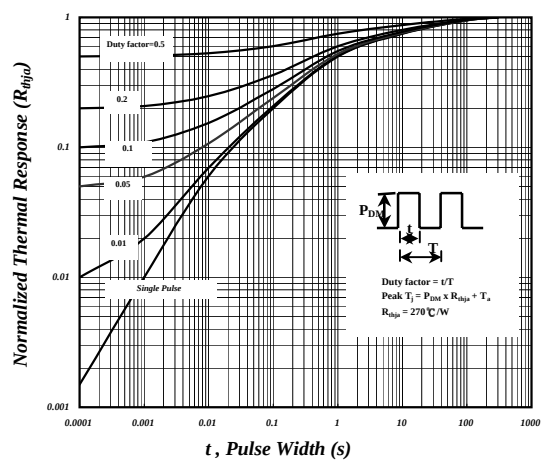


Fig 10. Effective Transient Thermal Impedance

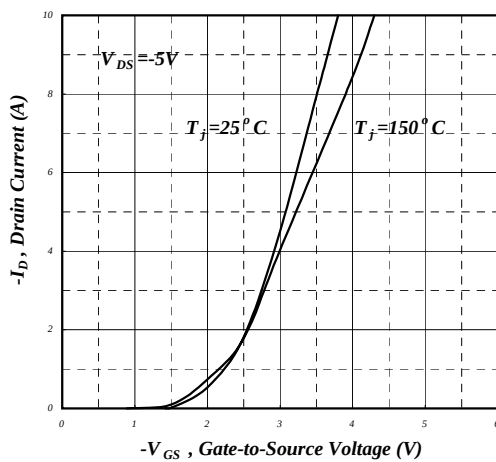


Fig 11. Transfer Characteristics

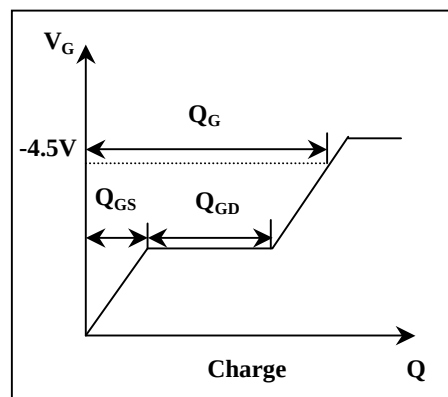


Fig 12. Gate Charge Circuit